

Enhancement Mode N-Channel Power MOSFET

SOT23-3/NMOS/30V/ \pm 20V/1.6V/5.8A/18m Ω

Rev0.7





30V, 18mΩ, 5.8A, Single N-Channel

1.Features

- ◆ 30V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V

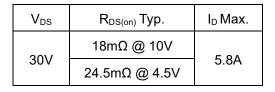
2.A	laa	icati	ions

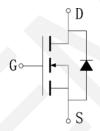
- Power Switching Application
- Load Switching



Pin Description

SOT23-3





Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.	
WP3404AS3	3404A	SOT23-3	3,000	180,000	

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{ extsf{DSS}}$	30	V
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	I _D	5.8	А
Drain Current (Pulse), PW≤300μs	I _{DP}	23	А
Total Dissipation	P_{D}	1.1	W
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{ heta JA}$	113	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10 \text{sec}$ The value in any given application depends on the user's specific board design.

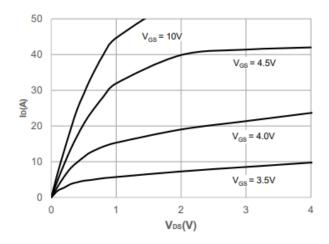
6.Electrical Characteristics at Ta=25°C (Note 3)

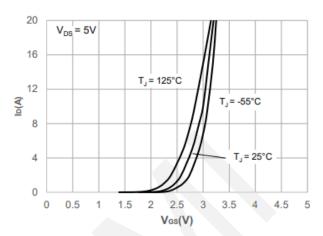
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	30	34		V
Zero-Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30V, V_{GS} = 0V$			1	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =250μA	1.1	1.6	2.5	V
Static Drain to Source On-State	Б	I _D = 5.5A, V _{GS} = 10V		18	24	mΩ
Resistance	R _{DS(on)}	I _D = 4.5A, V _{GS} =4.5V		24.5	38	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		485		pF
Output Capacitance	C _{oss}	V _{DS} =15V,		69		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		53		pF
Turn-ON Delay Time	t _{d(on)}			4		ns
Rise Time	t _r	$V_{DD} = 15V, R_L=3\Omega,$ $V_{GS} = 10V, R_G = 3\Omega$		11		ns
Turn-OFF Delay Time	$t_{d(off)}$			14		ns
Fall Time	t _f			2		ns
	Q_g	V _{DS} = 15V, V _{GS} = 10V,		10		nC
Total Gate Charge	Q _{gs}			2		nC
	Q_{gd}	I _D = 5.8A		2		nC
Diode Forward Voltage	V_{FSD}	I _S = 5.8A, V _{GS} = 0	0.5	0.8	1.1	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



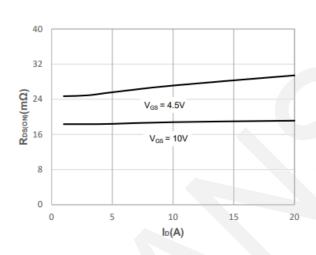
7. Typical Electrical and Thermal Characteristics

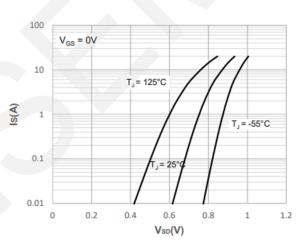




Output Characteristics

Typical Transfer Characteristics





Drain-Source On-Resistance

10 V_{DD} = 15V I_D = 5A

8

6

2

0

0

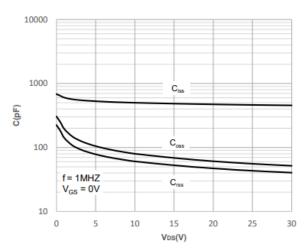
2

4

2

Qg(nC)

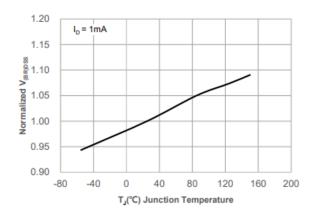
Body Diode Characteristics

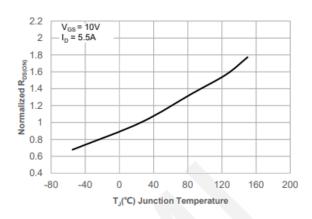


Gate Charge Characteristic

Capacitance Characteristics

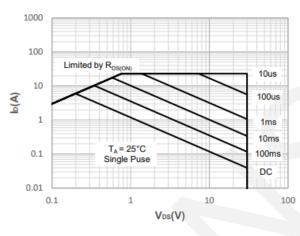


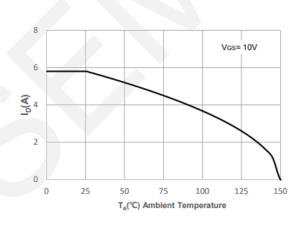




Normalized Breakdown voltage vs. Junction Temperature

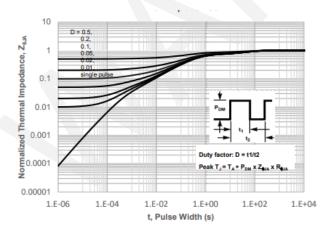
Normalized on Resistance vs. Junction Temperature

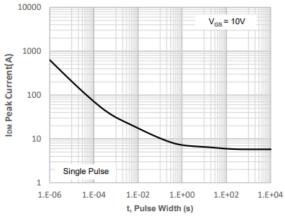




Maximum Safe Operating Area

Maximum Continuous Drian Current vs. Ambient Temperature





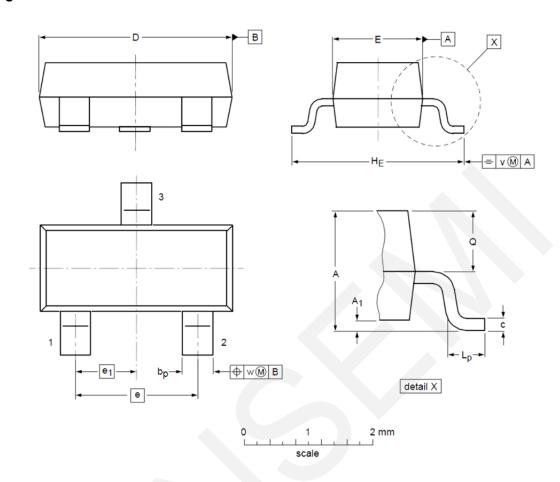
Normalized Maximum Transient

Peak Current Capacity

Thermal Impedance



8.Package Dimensions



DIMENSIONS (unit : mm)

Symbol	Min	Тур	Max	Symbol	Min	Тур	Max
A	1.00	1.17	1.30	A ₁	0.01	0.05	0.10
b _p	0.35	0.39	0.50	С	0.10	0.20	0.26
D	2.70	2.90	3.10	E	1.30	1.58	1.70
е		1.90		e ₁		0.95	
HE	2.50	2.78	3.00	L _p	0.20	0.32	0.60
Q	0.23	0.27	0.33	v		0.20	
w		0.20					



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